

Notice of References Cited	Application/Control No. 10/535,700		Applicant(s)/Patent Under Reexamination OOE ET AL.	
	Examiner JASON HECKERT		Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0157962	10-2002	Robey et al.	205/342
*	B	US-5,603,843	02-1997	Snee, Thomas M.	210/748
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	JP 2000-343081	12-2000	Japan	Sakamoto et al.	
*	O	JP 2001-276484	10-2001	Japan	Ando et al.	
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NON-PATENT DOCUMENTS

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	U	Translation of Abstract for JP 2000-343081, 12-2000
	V	Translation of JP 2001-276484, 10-2001
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.